

## 1 Product profile

### 1.1 General description

Planar PIN diode in a SOD882D leadless ultra small plastic SMD package.

#### 1.2 Features and benefits

- High-speed switching for RF signals
- Low diode capacitance
- · Low forward resistance
- · Very low series inductance
- For applications up to 3 GHz
- AEC-Q101 qualified

#### 1.3 Applications

RF attenuators and switches



## 2 Pinning information

Table 1. Discrete pinning

Pin	Description		Simplified outline	Symbol
1	cathode	[1]		1.4
2	anode		Transparent top view	sym006

<sup>[1]</sup> The marking bar indicates the cathode.

## 3 Ordering information

**Table 2. Ordering information** 

Type number	Package				
	Name	Description	Version		
BAP55LX	DFN1006D-2	leadless ultra small plastic package; 2 terminals; body 1 $\times$ 0.6 $\times$ 0.4 mm	SOD882D		

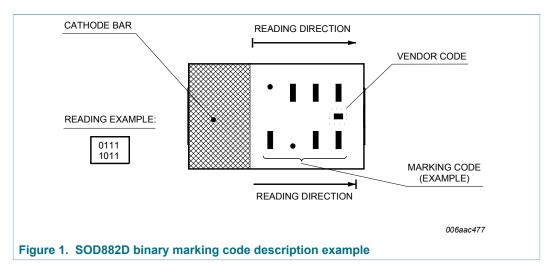
### 4 Marking

Table 3. Marking codes

Type number	Marking code <sup>[1]</sup>
BAP55LX	1111
	1101

<sup>[1]</sup> For SOD882D binary marking code description (see  $\underline{\text{Figure 1}}$ ).

### 4.1 Binary marking code description



BAP55LX

## 5 Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_R$	reverse voltage		-	50	V
l <sub>F</sub>	forward current		-	100	mA
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> ≤ 90 °C	-	135	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-65	+150	°C

## 6 Thermal characteristics

**Table 5. Thermal characteristics** 

Symbol	Parameter	Conditions	Тур	Unit
11(J-3P)	thermal resistance from junction to solder point		78	K/W

### 7 Characteristics

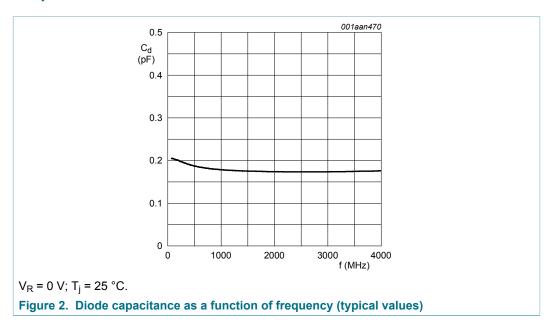
#### **Table 6. Characteristics**

 $T_{amb}$  = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
√ <sub>F</sub>	forward voltage	I <sub>F</sub> = 50 mA	-	0.95	1.1	V		
I <sub>R</sub>	reverse current	V <sub>R</sub> = 20 V	-	-	10	nA		
		V <sub>R</sub> = 50 V	-	-	100	nA		
C <sub>d</sub>	diode capacitance	f = 1 MHz (see <u>Figure 3</u> )						
		V <sub>R</sub> = 0 V	-	0.28	-	pF		
		V <sub>R</sub> = 1 V	-	0.23	-	pF		
		V <sub>R</sub> = 20 V	-	0.18	0.28	pF		
r <sub>D</sub>	diode forward resistance	f = 100 MHz (see Figure 4)						
		I <sub>F</sub> = 0.5 mA	-	3.3	4.5	Ω		
		I <sub>F</sub> = 1 mA	-	2.2	3.3	Ω		
		I <sub>F</sub> = 10 mA	-	0.8	1.2	Ω		
		I <sub>F</sub> = 100 mA	-	0.5	0.8	Ω		
SL	isolation	V <sub>R</sub> = 0 V (see <u>Figure 5</u> )						
		f = 900 MHz	-	19	-	dB		
		f = 1800 MHz	-	14	-	dB		
		f = 2450 MHz	-	12	-	dB		
L <sub>ins</sub>	insertion loss	(See Figure 6)						
		I <sub>F</sub> = 0.5 mA						
		f = 900 MHz	-	0.24	-	dB		
		f = 1800 MHz	-	0.25	-	dB		
		f = 2450 MHz	-	0.26	-	dB		
		I <sub>F</sub> = 1 mA						
		f = 900 MHz	-	0.17	-	dB		
		f = 1800 MHz	-	0.18	-	dB		
		f = 2450 MHz	-	0.19	-	dB		
		I <sub>F</sub> = 10 mA;						
		f = 900 MHz	-	0.08	-	dB		
		f = 1800 MHz	-	0.09	-	dB		
		f = 2450 MHz	-	0.10	-	dB		
		I <sub>F</sub> = 100 mA;						
		f = 900 MHz	-	0.05	-	dB		
		f = 1800 MHz	-	0.07	-	dB		
		f = 2450 MHz	_	0.08	_	dB		

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
τμ	charge carrier life time	when switched from $I_F$ = 10 mA to $I_R$ = 6 mA; $R_L$ = 100 $\Omega$ ; measured at $I_R$ = 3 mA	0.225	0.27	-	μs
L <sub>S</sub>	series inductance	I <sub>F</sub> = 100 mA; f = 100 MHz	-	0.4	-	nH

### 7.1 Graphical data



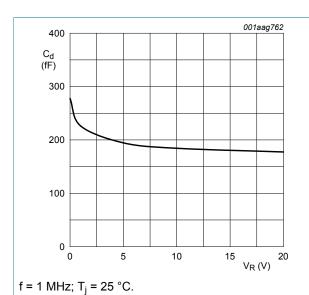
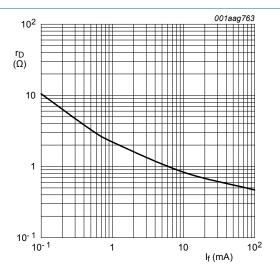
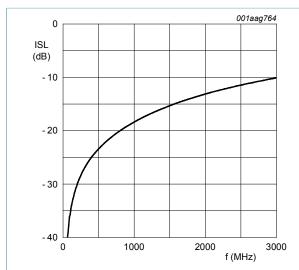


Figure 3. Diode capacitance as a function of reverse voltage (typical values)



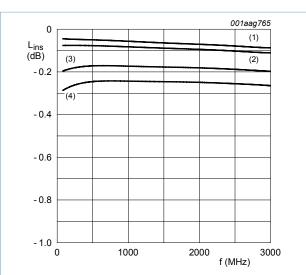
 $f = 100 \text{ MHz}; T_i = 25 ^{\circ}\text{C}.$ 

Figure 4. Forward resistance as a function of forward current (typical values)



 $T_{amb} = 25 \, ^{\circ}C$ 

Diode zero biased and inserted in series with a 50  $\Omega$  stripline circuit



T<sub>amb</sub> = 25 °C

Diode inserted in series with a 50  $\Omega$  stripline circuit and biased via the analyzer T-network

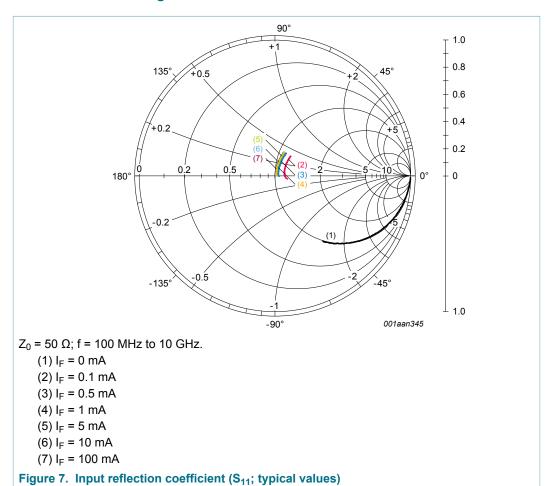
- (1)  $I_F = 100 \text{ mA}$
- (2)  $I_F = 10 \text{ mA}$
- (3)  $I_F = 1 \text{ mA}$
- (4)  $I_F = 0.5 \text{ mA}$

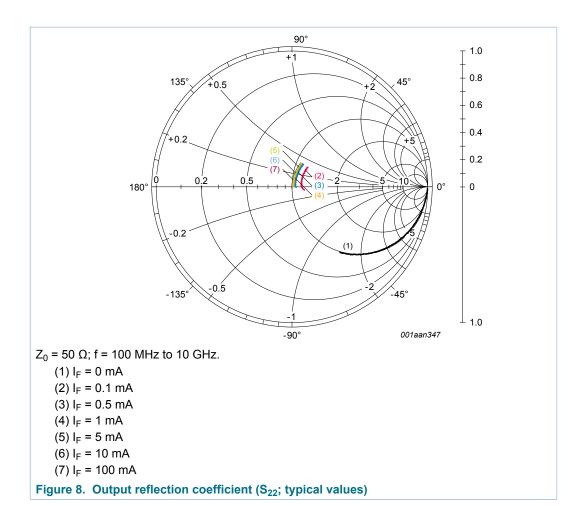
Figure 5. Isolation of the diode as a function of frequency (typical values)

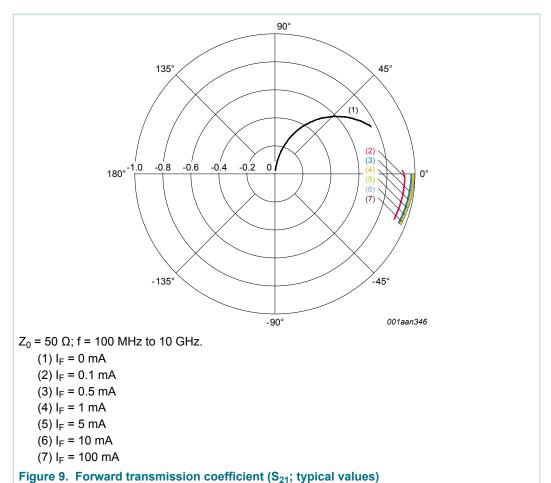
Figure 6. Insertion loss of the diode as a function of frequency (typical values)

### 7.2 S-parameters

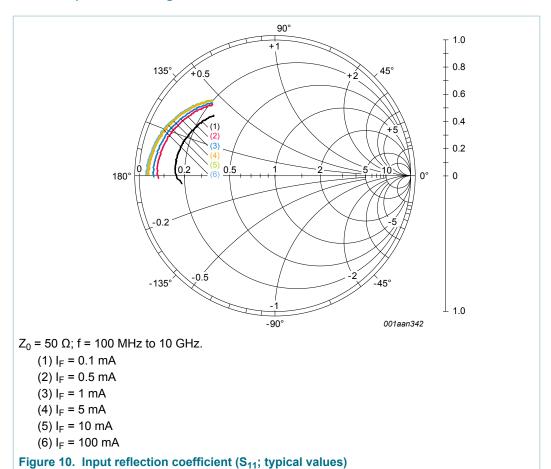
#### 7.2.1 Diode in series configuration

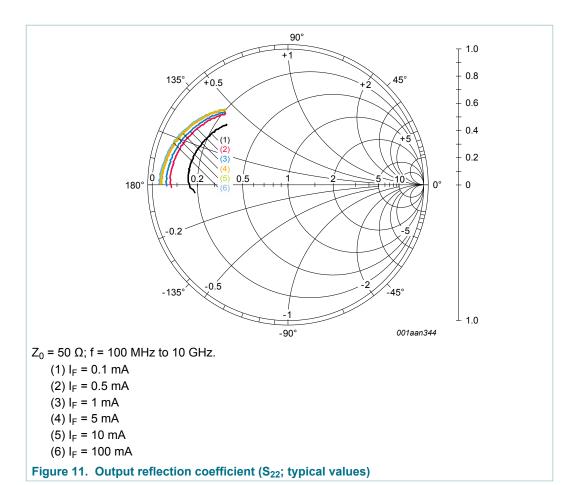


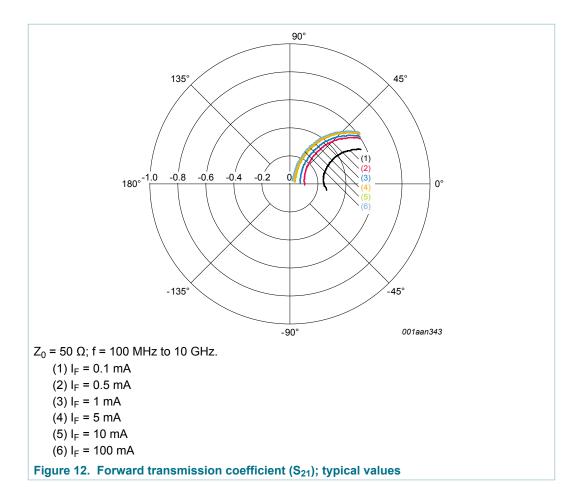




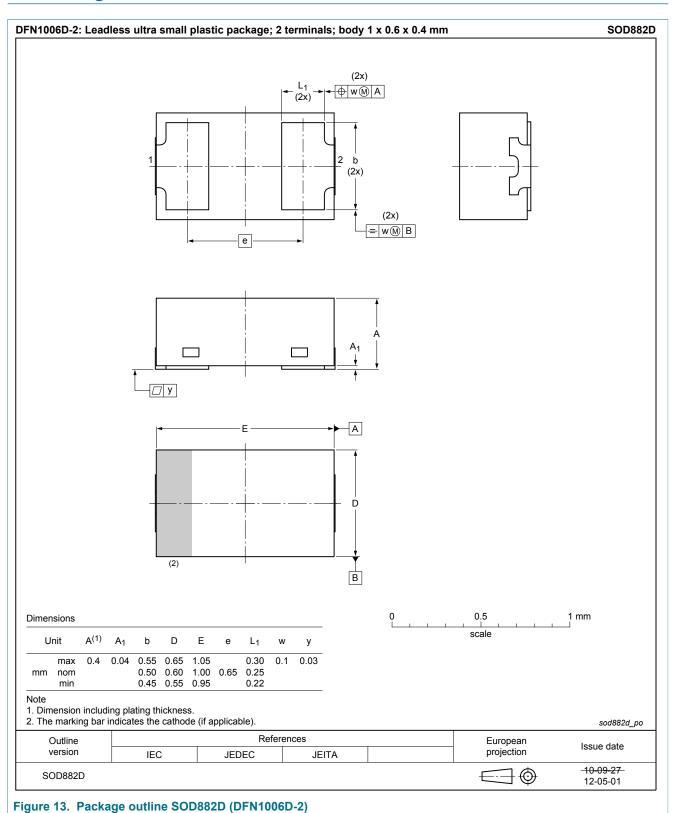
### 7.2.2 Diode in parallel configuration







## 8 Package outline





### 9 Abbreviations

Table 7. Abbreviations

Acronym	Description
PIN	P-type, intrinsic, N-type
SMD	surface-mounted device
RF	radio frequency

# 10 Revision history

#### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BAP55LX v.5	20190212	Product data sheet	-	BAP55LX v.4
Modifications:		eatures and benefits" has primation pages have been	•	
BAP55LX v.4	20130806	Product data sheet	-	BAP55LX v.3
BAP55LX v.3	20110113	Product data sheet	-	BAP55LX v.2
BAP55LX v.2	20101216	Product data sheet	-	BAP55LX v.1
BAP55LX v.1	20070730	Product data sheet	-	-

### 11 Legal information

#### 11.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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